



BENHA UNIVERSITY
FACULTY OF ENGINEERING (SHOUBRA)
ELECTRONICS AND COMMUNICATIONS ENGINEERING



CCE 201
Solid State Electronic Devices
(2022 - 2023) term 231

Lecture 3: Semiconductor Physics (part 3).

Dr. Ahmed Samir

<https://bu.edu.eg/staff/ahmedsaied>

Outlines



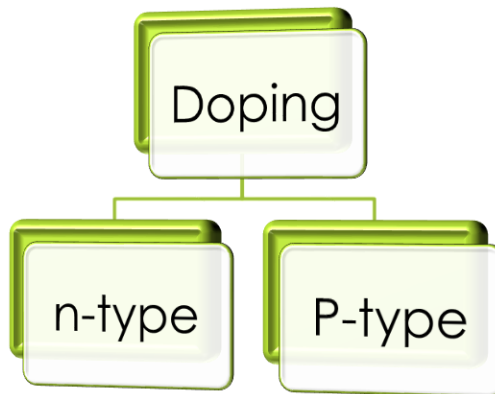
Revision.

Charge Neutrality.

Summary.

Revision:

- Q: Why can **thermal generation not** be used to affect meaningful current conduction?
 - ❑ A: Silicon crystal structure described previously **is not sufficiently conductive at room temperature**.
 - ❑ Additionally, a dependence on temperature is not desirable.
- How can this “problem” be fixed?
 - ❑ A: **doping** is the intentional introduction of impurities into an extremely pure (intrinsic) semiconductor for the purpose changing carrier concentrations.



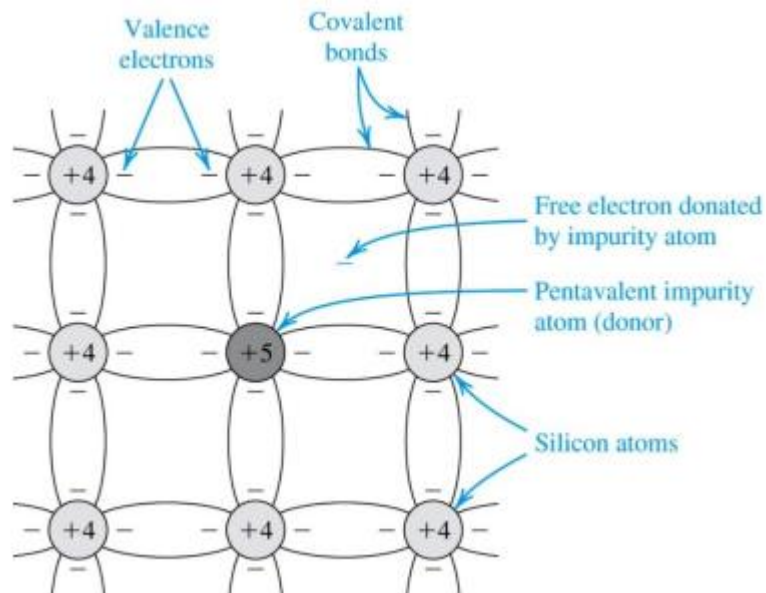
Revision:

➤ Doped Semiconductors :

A semiconductor material that has been subjected to the doping process is called an extrinsic material

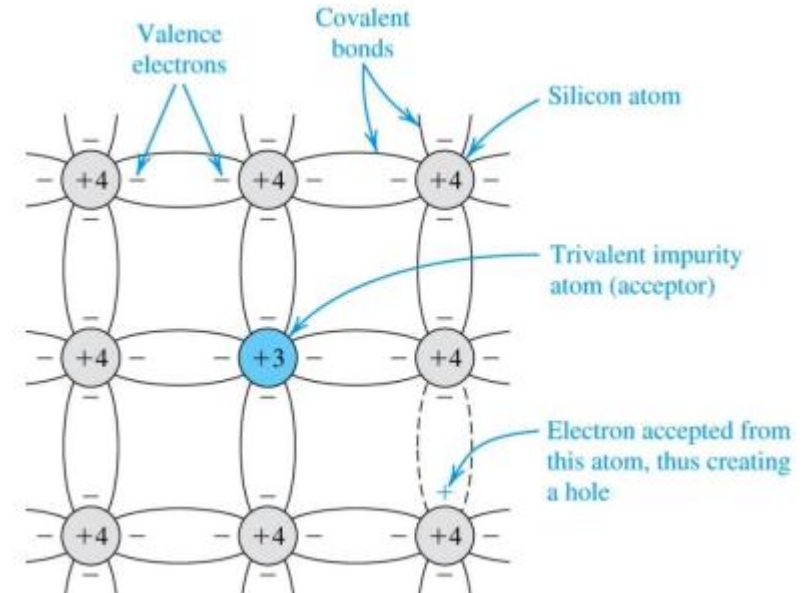
n-type semiconductor

- ❑ Silicon is doped with element having a valence of 5.
- ❑ To increase the concentration of free electrons (n).
- ❑ electrons are the majority charge carriers.
- ❑ holes are the minority charge carrier.
- ❑ One example is phosphorus, which is a donor.



p-type semiconductor

- ❑ Silicon is doped with element having a valence of 3.
- ❑ To increase the concentration of holes (p).
- ❑ holes are the majority charge carriers.
- ❑ electrons are the minority charge carrier.
- ❑ One example is boron, which is an acceptor.



Revision:

$$F(E) = \frac{1}{1 + e^{[(E-E_F)/kT]}}$$

$$n_i = N_c e^{-(E_c - E_{Fi})/kT}$$

$$n = n_i \exp(E_F - E_{Fi}/KT)$$

$$N_c = 2 \left(\frac{2\pi m_e kT}{h^2} \right)^{3/2}$$

$$n_i = \sqrt{N_c N_v} e^{(-E_g/2kT)}$$

$$p_i = N_v e^{-(E_{Fi} - E_v)/kT}$$

$$p = n_i \exp(E_{Fi} - E_F/KT)$$

$$N_v = 2 \left(\frac{2\pi m_h kT}{h^2} \right)^{3/2}$$

$$E_{Fi} = \frac{E_c + E_v}{2} + \frac{kT}{2} \ln \frac{N_v}{N_c}$$

$$E_{Fn} = E_{Fi} + kT \ln \frac{n}{n_i}$$

$$E_{Fi} = \frac{E_c + E_v}{2} + \frac{3}{4} kT \ln \frac{m_h}{m_e}$$

$$E_{Fp} = E_{Fi} - kT \ln \frac{p}{n_i}$$

Outlines



Revision.

Charge Neutrality.

Summary.

Charge Neutrality Equation:

- So far, we have learnt how to calculate the **carrier concentrations** n and p if we know the Fermi energy E_F relative to E_C or E_V .
- However, how do we know where is E_F ? In fact, we do not know. What is in **our control is the doping concentration**.
- So, we need to be able to **calculate the carrier concentrations** from the **impurity concentrations**, N_D and N_A .

What is charge neutrality equation?

- It is simply a statement of the **charge neutrality condition**.
- A semiconductor in **equilibrium** is **charge neutral** everywhere inside the sample. If it **were not neutral**, then there **will be electric fields** that will give rise to **electric currents** against the assumption of equilibrium.

$$n + N_A^- = p + N_D^+$$

Negative ions

Positive ions

Charge Neutrality Equation:

Solution of charge neutrality equation (n-type):

From $n_n + N_A = p_n + N_D$ and $n_n \times p_n = n_i^2$

By solving these two equations, we get n and p

$$n_n = \frac{N_D - N_A}{2} + \sqrt{\left(\frac{N_D - N_A}{2}\right)^2 + n_i^2}$$

Once n is known, p is obtained by using the equation.

$$p_n = \frac{n_i^2}{n_n}$$

Charge Neutrality Equation:

(n-type) Special cases

$$n_n = \frac{N_D - N_A}{2} + \sqrt{\left(\frac{N_D - N_A}{2}\right)^2 + n_i^2}$$

$$n_n = \frac{N_D}{2} + \sqrt{\left(\frac{N_D}{2}\right)^2 + n_i^2} \quad N_A = 0$$

$$n_n = N_D - N_A \quad \frac{N_D - N_A}{2} \gg n_i \text{ So we can neglect } n_i \text{ w.r.t. } \frac{N_D - N_A}{2}$$

$$n_n = N_D \quad N_A = 0, N_D \gg n_i$$

Once n is known, p is obtained by using the equation.

$$p_n = \frac{n_i^2}{n_n}$$

Charge Neutrality Equation:

Solution of charge neutrality equation (p-type):

From $n_p + N_A = p_p + N_D$ and $n_p \times p_p = n_i^2$

By solving these two equations, we get p and n

$$\frac{n_i^2}{p} + N_A = p + N_D$$

$$p^2 + (N_D - N_A)p - n_i^2 = 0$$

$$p_p = \frac{N_A - N_D}{2} + \sqrt{\left(\frac{N_A - N_D}{2}\right)^2 + n_i^2}$$

Once p is known, n is obtained by using the equation.

$$n_p = \frac{n_i^2}{p_p}$$

Charge Neutrality Equation:

(n-type) Special cases

$$p_p = \frac{N_A - N_D}{2} + \sqrt{\left(\frac{N_A - N_D}{2}\right)^2 + n_i^2}$$

$$p_p = \frac{N_A}{2} + \sqrt{\left(\frac{N_A}{2}\right)^2 + n_i^2} \quad N_D = 0$$

$$p_p = N_A - N_D \quad \frac{N_A - N_D}{2} \gg n_i \text{ So we can neglect } n_i \text{ w.r.t. } \frac{N_A - N_D}{2}$$

$$p_p = N_A \quad N_D = 0, N_A \gg n_i$$

Once n is known, p is obtained by using the equation.

$$n_p = \frac{n_i^2}{p_p}$$

Example 1:

Consider an n-type silicon for which the dopant concentration is $N_D = 10^{17}/\text{cm}^3$. Find the electron and hole concentrations at $T = 300\text{K}$.

Solution

The concentration of the majority electrons is

$$n_n \simeq N_D = 10^{17} / \text{cm}^3$$

The concentration of the minority holes is

$$p_n \simeq \frac{n_i^2}{N_D}$$

In Example 1, we found that at $T = 300\text{ K}$,

$$n_i = 1.5 \times 10^{10} / \text{cm}^3. \text{ Thus,}$$

$$p_n \simeq \frac{(1.5 \times 10^{10})^2}{10^{17}} = 2.25 \times 10^3 / \text{cm}^3$$

Observe that $n_n \gg n_i$ and that n_n is vastly higher than p_n .

Example 2:

For a silicon crystal doped with boron, what must N_A be if at $T = 300$ K the electron concentration drops below the intrinsic level by a factor of 10^6 ?

Solution

$$\text{At } 300 \text{ K, } n_i = 1.5 \times 10^{10}/\text{cm}^3$$

$$p_p = N_A$$

Want electron concentration

$$= n_p = \frac{1.5 \times 10^{10}}{10^6} = 1.5 \times 10^4/\text{cm}^3$$

$$\therefore N_A = p_p = \frac{n_i^2}{n_p}$$

$$= \frac{(1.5 \times 10^{10})^2}{1.5 \times 10^4}$$

$$= 1.5 \times 10^{16}/\text{cm}^3$$

Example 3:

A silicon sample is doped with $2 \times 10^{15} \text{ cm}^{-3}$ P atoms. If the background acceptor impurity concentration is $1 \times 10^{15} \text{ cm}^{-3}$ calculate the electron and hole concentrations in this sample. Assume complete ionization of all the impurities and the intrinsic carrier concentration in Si at room temperature to be 10^{10} cm^{-3} .

Solution

$$n = N_D - N_A = 2 \times 10^{15} - 1 \times 10^{15} = 1 \times 10^{15} \text{ cm}^{-3}.$$

$$p = n_i^2 / n = (10^{10})^2 / 1 \times 10^{15} = 10^{20} / 10^{15} = 10^5 \text{ cm}^{-3}.$$

Example 4:

An n-type Si sample has a donor concentration of 10^{16} cm^{-3} . Suppose we want to convert this sample into p-type with a hole concentration of $5 \times 10^{15} \text{ cm}^{-3}$, what impurity and at what concentration would you use?

Solution: $p = N_A - N_D \Rightarrow N_A = p + N_D = 5 \times 10^{15} + 1 \times 10^{16} = 1.5 \times 10^{16} \text{ cm}^{-3}$. We need to use an acceptor impurity such as B at a concentration of $1.5 \times 10^{16} \text{ cm}^{-3}$.

Summary:

$$n = \frac{N_D - N_A}{2} + \sqrt{\left(\frac{N_D - N_A}{2}\right)^2 + n_i^2}$$

$$p = \frac{N_A - N_D}{2} + \sqrt{\left(\frac{N_A - N_D}{2}\right)^2 + n_i^2}$$



END OF LECTURE

BEST WISHES